

**Search Notes**

Application/Control No.

10/612,765

Examiner

John L. Goodrow

Applicant(s)/Patent under  
Reexamination

QIAN ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	117	3/6/2006	JG
	115		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR